

Notice of References Cited	Application/Control No. 10/562,481	Applicant(s)/Patent Under Reexamination LEE, BYOUNG-RAE	
	Examiner JOHN PAK	Art Unit 1616	Page 1 of 1

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	U	Derwent Abstract 1992-214190 (1992).
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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